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QUERY CONTROL FORM		RTIS USE ONLY	
Application No.	<u>09/540,288</u>	Prepared by	<u>NPB</u>
Examiner-GAU	<u>JAYE - 2879</u>	Date	<u>2/18/04</u>
		No. of queries	<u>3</u>
		Tracking Number	<u>0588/958</u>
		Week Date	<u>2/29/03</u>
			<u>IPW</u>

JACKET

a. Serial No.	f. Foreign Priority	k. Print Claim(s)	p. PTO-1449
b. Applicant(s)	g. Disclaimer	l. Print Fig.	q. PTOL-85b
c. Continuing Data	h. Microfiche Appendix	m. Searched Column	r. <u>Abstract</u>
d. PCT	i. Title	n. PTO-270/328	s. Sheets/Figs
e. Domestic Priority	j. Claims Allowed	o. PTO-892	t. Other

SPECIFICATION	MESSAGE	
	(1) There are two(2) claim 72's in the index of claims and no claim 71. Please advise.	
	(2) claim 126 (was original claim 316) depends on a high claim number 129 (original claim 310). Please advise/correct claim dependency.	
	(2) Abstract is too long: Please shorten Abstract, in light of MPEP 628.01(b), paragraph entitled "Language and Format".	
CLAIMS	<i>Thank you</i>	
	initials <i>[Signature]</i>	
	RESPONSE _____	
	initials	

Issue Classification				Application No.	Applicant(s)	
				09/540,288	WU ET AL.	
				Examiner	Art Unit	
				Mariceli Santiago	2879	

ISSUE CLASSIFICATION					
ORIGINAL		CROSS REFERENCE(S)			
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)		
313	503	313	504	506	509
INTERNATIONAL CLASSIFICATION		315	169.3		
H 0 5 B	33/00	428	690		
H 0 5 B	33/02				
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	/				
	/				
Mariceli Santiago 11/25/2003 (Assistant Examiner) (Date)				Total Claims Allowed: 137	
(Legal Instruments Examiner) (Date)		(Primary Examiner)	(Date)	O.G. Print Claim(s) 1	O.G. Print Fig. 1 2

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
211		241	35 271	65	301	83	331
212		242	37 272	52	302	84	332
213		1 243	2 273	57	303	46	333
214		244	274	62	304	49	334
215		7 245	38 275	68	305	64	335
216		12 246	39 276	119	306	67	336
217		5 247	40 277	124	307	76	337
218		10 248	41 278	125	308	120	338
219		15 249	42 279	121	309	72	339
220		3 250	43 280	129	310	75	340
221		8 251	19 281	128	311	85	341
222		13 252	20 282	122	312	77	342
223		17 253	21 283	130	313	86	343
224		6 254	22 284	127	314	87	344
225		11 255	23 285	123	315	88	345
226		16 256	24 286	126	316	91	346
227		4 257	25 287	131	317	92	347
228		9 258	244 288	47	318	93	348
229		14 259	48 289	50	319	94	349
230		18 260	55 290	132	320	99	350
231		26 261	60 291	133	321	96	351
232		30 262	53 292	134	322	95	352
233		31 263	58 293	135	323	100	353
234		27 264	63 294	136	324	97	354
235		34 265	51 295	137	325	102	355
236		33 266	56 296	69	326	103	356
237		28 267	61 297	70	327	104	357
238		36 268	66 298	72	328	105	358
239		32 269	54 299	73	329	106	359
240		29 270	59 300	74	330	107	360

U.S. Patent and Trademark Office

Part of Paper No. 20031125

Two(2) claim 72's, no claim 71. Please advise.

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Conf'd

phosphor deposits, whereby the blue sub-pixel elements are provided by SrS:Ce and the red and green sub-pixel elements are provided by SrS:Ce and one or both of ZnS:Mn or Zn_xMg_{1-x}S:Mn.

129 310. The EL laminate as set forth in claim ~~308~~¹²⁵, wherein the means for setting and equalizing the threshold voltages and for setting the relative luminosities comprises a threshold voltage adjustment layer over the red and green sub-pixel phosphor deposits.

128 311. The EL laminate as set forth in claim ~~308~~¹²⁵, wherein the means for setting and equalizing the threshold voltages and for setting the relative luminosities comprises the phosphor deposits being formed with different thicknesses.

122 312. The EL laminate as set forth in claim ~~309~~¹²¹, wherein the means for setting and equalizing the threshold voltages and for setting the relative luminosities comprises the phosphor deposits being formed with different thicknesses.

130 313. The EL laminate as set forth in claim ~~310~~¹²⁹, wherein the means for setting and equalizing the threshold voltages and for setting the relative luminosities comprises the phosphor deposits being formed with different thicknesses.

121 314. The EL laminate as set forth in claim ~~308~~¹²⁵, wherein the means for setting and equalizing the threshold voltages and for setting the relative luminosities comprises varying the areas of one or more of the sub-pixel phosphor deposits.

123 315. The EL laminate as set forth in claim ~~309~~¹²¹, wherein the means for setting and equalizing the threshold voltages and for setting the relative luminosities comprises varying the areas of one or more of the sub-pixel phosphor deposits.

126 316. The EL laminate as set forth in claim ~~310~~¹²⁹, wherein the means for setting and equalizing the threshold voltages and for setting the relative luminosities comprises varying the areas of one or more of the sub-pixel phosphor deposits.

131 317. The EL laminate as set forth in claim ~~313~~¹³⁰, wherein the means for setting and equalizing the threshold voltages and for setting the relative luminosities comprises varying the areas of one or more of the sub-pixel phosphor deposits.

41 318. The EL laminate as set forth claim ~~288~~⁴⁴, wherein the means for setting and equalizing the threshold voltages, and for setting the relative luminosities, comprises a threshold voltage adjustment layer selected from the group consisting of one or more of a dielectric material or a semiconductor material, which, at its deposited thickness, does not conduct until the voltage across the patterned phosphor structure exceeds the threshold voltage which the patterned